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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Discontinued at Digi-Key
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	24MHz
Connectivity	EBI/EMI, I ² C, IrDA, SmartCard, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, I ² S, POR, PWM, WDT
Number of I/O	37
Program Memory Size	4KB (4K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.98V ~ 3.8V
Data Converters	A/D 4x12b; D/A 1x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	48-TQFP
Supplier Device Package	48-TQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/silicon-labs/efm32zg222f4-qfp48

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

2 System Summary

2.1 System Introduction

The EFM32 MCUs are the world's most energy friendly microcontrollers. With a unique combination of the powerful 32-bit ARM Cortex-M0+, innovative low energy techniques, short wake-up time from energy saving modes, and a wide selection of peripherals, the EFM32ZG microcontroller is well suited for any battery operated application as well as other systems requiring high performance and low-energy consumption. This section gives a short introduction to each of the modules in general terms and also shows a summary of the configuration for the EFM32ZG222 devices. For a complete feature set and indepth information on the modules, the reader is referred to the *EFM32ZG Reference Manual*.

A block diagram of the EFM32ZG222 is shown in Figure 2.1 (p. 3) .



Figure 2.1. Block Diagram

2.1.1 ARM Cortex-M0+ Core

The ARM Cortex-M0+ includes a 32-bit RISC processor which can achieve as much as 0.9 Dhrystone MIPS/MHz. A Wake-up Interrupt Controller handling interrupts triggered while the CPU is asleep is included as well. The EFM32 implementation of the Cortex-M0+ is described in detail in *ARM Cortex-M0+ Devices Generic User Guide*.

2.1.2 Debug Interface (DBG)

This device includes hardware debug support through a 2-pin serial-wire debug interface .

2.1.3 Memory System Controller (MSC)

The Memory System Controller (MSC) is the program memory unit of the EFM32ZG microcontroller. The flash memory is readable and writable from both the Cortex-M0+ and DMA. The flash memory is divided into two blocks; the main block and the information block. Program code is normally written to the main block. Additionally, the information block is available for special user data and flash lock bits. There is also a read-only page in the information block containing system and device calibration data. Read and write operations are supported in the energy modes EM0 and EM1.

2.1.4 Direct Memory Access Controller (DMA)

The Direct Memory Access (DMA) controller performs memory operations independently of the CPU. This has the benefit of reducing the energy consumption and the workload of the CPU, and enables the system to stay in low energy modes when moving for instance data from the USART to RAM or from the External Bus Interface to a PWM-generating timer. The DMA controller uses the PL230 μ DMA controller licensed from ARM.

2.1.5 Reset Management Unit (RMU)

EFM[®]32

The RMU is responsible for handling the reset functionality of the EFM32ZG.

2.1.6 Energy Management Unit (EMU)

The Energy Management Unit (EMU) manage all the low energy modes (EM) in EFM32ZG microcontrollers. Each energy mode manages if the CPU and the various peripherals are available. The EMU can also be used to turn off the power to unused SRAM blocks.

2.1.7 Clock Management Unit (CMU)

The Clock Management Unit (CMU) is responsible for controlling the oscillators and clocks on-board the EFM32ZG. The CMU provides the capability to turn on and off the clock on an individual basis to all peripheral modules in addition to enable/disable and configure the available oscillators. The high degree of flexibility enables software to minimize energy consumption in any specific application by not wasting power on peripherals and oscillators that are inactive.

2.1.8 Watchdog (WDOG)

The purpose of the watchdog timer is to generate a reset in case of a system failure, to increase application reliability. The failure may e.g. be caused by an external event, such as an ESD pulse, or by a software failure.

2.1.9 Peripheral Reflex System (PRS)

The Peripheral Reflex System (PRS) system is a network which lets the different peripheral module communicate directly with each other without involving the CPU. Peripheral modules which send out Reflex signals are called producers. The PRS routes these reflex signals to consumer peripherals which apply actions depending on the data received. The format for the Reflex signals is not given, but edge triggers and other functionality can be applied by the PRS.

2.1.10 Inter-Integrated Circuit Interface (I2C)

The I^2C module provides an interface between the MCU and a serial I^2C -bus. It is capable of acting as both a master and a slave, and supports multi-master buses. Both standard-mode, fast-mode and fast-mode plus speeds are supported, allowing transmission rates all the way from 10 kbit/s up to 1 Mbit/s. Slave arbitration and timeouts are also provided to allow implementation of an SMBus compliant system. The interface provided to software by the I^2C module, allows both fine-grained control of the transmission process and close to automatic transfers. Automatic recognition of slave addresses is provided in all energy modes.

2.1.11 Universal Synchronous/Asynchronous Receiver/Transmitter (US-ART)

The Universal Synchronous Asynchronous serial Receiver and Transmitter (USART) is a very flexible serial I/O module. It supports full duplex asynchronous UART communication as well as RS-485, SPI, MicroWire and 3-wire. It can also interface with ISO7816 SmartCards, IrDA and I2S devices.

2.1.12 Pre-Programmed UART Bootloader

The bootloader presented in application note AN0003 is pre-programmed in the device at factory. Autobaud and destructive write are supported. The autobaud feature, interface and commands are described further in the application note.

2.1.13 Low Energy Universal Asynchronous Receiver/Transmitter (LEUART)

The unique LEUARTTM, the Low Energy UART, is a UART that allows two-way UART communication on a strict power budget. Only a 32.768 kHz clock is needed to allow UART communication up to 9600 baud/s. The LEUART includes all necessary hardware support to make asynchronous serial communication possible with minimum of software intervention and energy consumption.

2.1.14 Timer/Counter (TIMER)

The 16-bit general purpose Timer has 3 compare/capture channels for input capture and compare/Pulse-Width Modulation (PWM) output.

2.1.15 Real Time Counter (RTC)

The Real Time Counter (RTC) contains a 24-bit counter and is clocked either by a 32.768 kHz crystal oscillator, or a 32.768 kHz RC oscillator. In addition to energy modes EM0 and EM1, the RTC is also available in EM2. This makes it ideal for keeping track of time since the RTC is enabled in EM2 where most of the device is powered down.

2.1.16 Pulse Counter (PCNT)

The Pulse Counter (PCNT) can be used for counting pulses on a single input or to decode quadrature encoded inputs. It runs off either the internal LFACLK or the PCNTn_S0IN pin as external clock source. The module may operate in energy mode EM0 - EM3.

2.1.17 Analog Comparator (ACMP)

The Analog Comparator is used to compare the voltage of two analog inputs, with a digital output indicating which input voltage is higher. Inputs can either be one of the selectable internal references or from external pins. Response time and thereby also the current consumption can be configured by altering the current supply to the comparator.

2.1.18 Voltage Comparator (VCMP)

The Voltage Supply Comparator is used to monitor the supply voltage from software. An interrupt can be generated when the supply falls below or rises above a programmable threshold. Response time and thereby also the current consumption can be configured by altering the current supply to the comparator.

2.1.19 Analog to Digital Converter (ADC)

The ADC is a Successive Approximation Register (SAR) architecture, with a resolution of up to 12 bits at up to one million samples per second. The integrated input mux can select inputs from 4 external pins and 6 internal signals.

2.1.20 Current Digital to Analog Converter (IDAC)

The current digital to analog converter can source or sink a configurable constant current, which can be output on, or sinked from pin or ADC. The current is configurable with several ranges of various step sizes.

2.1.21 Advanced Encryption Standard Accelerator (AES)

The AES accelerator performs AES encryption and decryption with 128-bit. Encrypting or decrypting one 128-bit data block takes 52 HFCORECLK cycles with 128-bit keys. The AES module is an AHB slave which enables efficient access to the data and key registers. All write accesses to the AES module must be 32-bit operations, i.e. 8- or 16-bit operations are not supported.

2.1.22 General Purpose Input/Output (GPIO)

In the EFM32ZG222, there are 37 General Purpose Input/Output (GPIO) pins, which are divided into ports with up to 16 pins each. These pins can individually be configured as either an output or input. More advanced configurations like open-drain, filtering and drive strength can also be configured individually for the pins. The GPIO pins can also be overridden by peripheral pin connections, like Timer PWM outputs or USART communication, which can be routed to several locations on the device. The GPIO supports up to 16 asynchronous external pin interrupts, which enables interrupts from any pin on the device. Also, the input value of a pin can be routed through the Peripheral Reflex System to other peripherals.

2.2 Configuration Summary

The features of the EFM32ZG222 is a subset of the feature set described in the EFM32ZG Reference Manual. Table 2.1 (p. 6) describes device specific implementation of the features.

Module	Configuration	Pin Connections
Cortex-M0+	Full configuration	NA
DBG	Full configuration	DBG_SWCLK, DBG_SWDIO,
MSC	Full configuration	NA
DMA	Full configuration	NA
RMU	Full configuration	NA
EMU	Full configuration	NA
СМU	Full configuration	CMU_OUT0, CMU_OUT1
WDOG	Full configuration	NA
PRS	Full configuration	NA
I2C0	Full configuration	I2C0_SDA, I2C0_SCL
USART1	Full configuration with I2S and IrDA	US1_TX, US1_RX, US1_CLK, US1_CS
LEUART0	Full configuration	LEU0_TX, LEU0_RX
TIMER0	Full configuration	TIM0_CC[2:0]
TIMER1	Full configuration	TIM1_CC[2:0]
RTC	Full configuration	NA
PCNT0	Full configuration, 16-bit count register	PCNT0_S[1:0]
ACMP0	Full configuration	ACMP0_CH[4:0], ACMP0_O
VCMP	Full configuration	NA
ADC0	Full configuration	ADC0_CH[3:0]
IDAC0	Full configuration	IDAC0_OUT
AES	Full configuration	NA

Table 2.1. Configuration Summary



Symbol	Parameter	Condition	Min	Тур	Мах	Unit
		14 MHz HFRCO, all peripher- al clocks disabled, V_{DD} = 3.0 V, T_{AMB} =25°C		50	54	µA/ MHz
		14 MHz HFRCO, all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =85°C		51	56	µA/ MHz
		11 MHz HFRCO, all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =25°C		52	56	µA/ MHz
		11 MHz HFRCO, all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =85°C		53	58	µA/ MHz
		6.6 MHz HFRCO, all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =25°C		57	63	μΑ/ MHz
		6.6 MHz HFRCO, all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =85°C		59	66	μΑ/ MHz
		1.2 MHz HFRCO. all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =25°C		89	99	μΑ/ MHz
		1.2 MHz HFRCO. all peripheral clocks disabled, V_{DD} = 3.0 V, T_{AMB} =85°C		92	103	µA/ MHz
1	EM2 current	EM2 current with RTC prescaled to 1 Hz, 32.768 kHz LFRCO, V_{DD} = 3.0 V, T_{AMB} =25°C		0.9	1.25	μA
I _{EM2}		EM2 current with RTC prescaled to 1 Hz, 32.768 kHz LFRCO, V_{DD} = 3.0 V, T_{AMB} =85°C		1.7	2.35	μA
I _{EM3}	EM3 current	EM3 current (ULFRCO en- abled, LFRCO/LFXO disabled), V _{DD} = 3.0 V, T _{AMB} =25°C		0.5	0.9	μA
	EIVI3 CUFFENT	EM3 current (ULFRCO en- abled, LFRCO/LFXO disabled), V _{DD} = 3.0 V, T _{AMB} =85°C		1.3	2.0	μA
	FM4 current	V _{DD} = 3.0 V, T _{AMB} =25°C		0.02	0.035	μA
I _{EM4}	EM4 current	V _{DD} = 3.0 V, T _{AMB} =85°C		0.29	0.700	μA

Figure 3.3. EM0 Current consumption while executing prime number calculation code from flash with HFRCO running at 14 MHz



Figure 3.4. EM0 Current consumption while executing prime number calculation code from flash with HFRCO running at 11 MHz



Figure 3.7. EM1 Current consumption with all peripheral clocks disabled and HFRCO running at 21 MHz



Figure 3.8. EM1 Current consumption with all peripheral clocks disabled and HFRCO running at 14 MHz



3.4.5 EM4 Current Consumption





3.5 Transition between Energy Modes

The transition times are measured from the trigger to the first clock edge in the CPU.

	Table 3.4.	Energy	Modes	Transitions
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Symbol	Parameter	Min	Тур	Max	Unit
t _{EM10}	Transition time from EM1 to EM0		0		HF- CORE- CLK cycles
t _{EM20}	Transition time from EM2 to EM0		2		μs
t _{EM30}	Transition time from EM3 to EM0		2		μs
t _{EM40}	Transition time from EM4 to EM0		163		μs

3.6 Power Management

The EFM32ZG requires the AVDD_x, VDD_DREG and IOVDD_x pins to be connected together (with optional filter) at the PCB level. For practical schematic recommendations, please see the application note, "AN0002 EFM32 Hardware Design Considerations".



Figure 3.18. Typical Low-Level Output Current, 3.8V Supply Voltage



GPIO_Px_CTRL DRIVEMODE = LOWEST



GPIO_Px_CTRL DRIVEMODE = STANDARD



GPIO_Px_CTRL DRIVEMODE = LOW



GPIO_Px_CTRL DRIVEMODE = HIGH

3.9 Oscillators

3.9.1 LFXO

Table 3.8. LFXO

Symbol	Parameter	Condition	Min	Тур	Max	Unit
f _{LFXO}	Supported nominal crystal frequency			32.768		kHz
ESR _{LFXO}	Supported crystal equivalent series re- sistance (ESR)			30	120	kOhm
C _{LFXOL}	Supported crystal external load range		5		25	pF
I _{LFXO}	Current consump- tion for core and buffer after startup.	ESR=30 kOhm, C _L =10 pF, LFXOBOOST in CMU_CTRL is 1		190		nA
t _{LFXO}	Start- up time.	ESR=30 kOhm, C _L =10 pF, 40% - 60% duty cycle has been reached, LFXOBOOST in CMU_CTRL is 1		1100		ms

For safe startup of a given crystal, the energyAware Designer in Simplicity Studio contains a tool to help users configure both load capacitance and software settings for using the LFXO. For details regarding the crystal configuration, the reader is referred to application note "AN0016 EFM32 Oscillator Design Consideration".

3.9.2 HFXO

Table 3.9. HFXO

Symbol	Parameter	Condition	Min	Тур	Max	Unit
f _{HFXO}	Supported nominal crystal Frequency		4		24	MHz
	Supported crystal	Crystal frequency 24 MHz		30	100	Ohm
ESR _{HFXO}	sistance (ESR)	Crystal frequency 4 MHz		400	1500	Ohm
9 _{mHFXO}	The transconduc- tance of the HFXO input transistor at crystal startup	HFXOBOOST in CMU_CTRL equals 0b11	20			mS
C _{HFXOL}	Supported crystal external load range		5		25	pF
I _{HFXO}	Current consump- tion for HFXO after startup	4 MHz: ESR=400 Ohm, C _L =20 pF, HFXOBOOST in CMU_CTRL equals 0b11		85		μA
		24 MHz: ESR=30 Ohm, C _L =10 pF, HFXOBOOST in CMU_CTRL equals 0b11		165		μA
t _{HFXO}	Startup time	24 MHz: ESR=30 Ohm, C_L =10 pF, HFXOBOOST in CMU_CTRL equals 0b11		785		μs



Symbol	Parameter	Condition	Min	Тур	Max	Unit
		Differential	-V _{REF} /2		V _{REF} /2	V
VADCREFIN	Input range of exter- nal reference volt- age, single ended and differential		1.25		V _{DD}	V
V _{ADCREFIN_CH7}	Input range of ex- ternal negative ref- erence voltage on channel 7	See V _{ADCREFIN}	0		V _{DD} - 1.1	V
V _{ADCREFIN_CH6}	Input range of ex- ternal positive ref- erence voltage on channel 6	See V _{ADCREFIN}	0.625		V _{DD}	V
V _{ADCCMIN}	Common mode in- put range		0		V _{DD}	V
I _{ADCIN}	Input current	2pF sampling capacitors		<100		nA
CMRR _{ADC}	Analog input com- mon mode rejection ratio			65		dB
	Average active cur- rent	1 MSamples/s, 12 bit, external reference		351	500	μA
		10 kSamples/s 12 bit, internal 1.25 V reference, WARMUP- MODE in ADCn_CTRL set to 0b00		67		μA
I _{ADC}		10 kSamples/s 12 bit, internal 1.25 V reference, WARMUP- MODE in ADCn_CTRL set to 0b01		63		μA
		10 kSamples/s 12 bit, internal 1.25 V reference, WARMUP- MODE in ADCn_CTRL set to 0b10		64		μA
I _{ADCREF}	Current consump- tion of internal volt- age reference	Internal voltage reference		65	127	μΑ
C _{ADCIN}	Input capacitance			2		pF
	Input ON resistance		1			MOhm
R _{ADCFILT}	Input RC filter resis- tance			10		kOhm
C _{ADCFILT}	Input RC filter/de- coupling capaci- tance			250		fF
f _{ADCCLK}	ADC Clock Fre- quency				13	MHz
		6 bit	7			ADC- CLK Cycles
^t ADCCONV	Conversion time	8 bit	11			ADC- CLK Cycles



Symbol	Parameter	Condition	Min	Тур	Мах	Unit
		1 MSamples/s, 12 bit, differen- tial, 2xV _{DD} reference		75		dBc
		1 MSamples/s, 12 bit, differen- tial, 5V reference		69		dBc
		200 kSamples/s, 12 bit, sin- gle ended, internal 1.25V refer- ence		75		dBc
		200 kSamples/s, 12 bit, single ended, internal 2.5V reference		75		dBc
		200 kSamples/s, 12 bit, single ended, V _{DD} reference		76		dBc
		200 kSamples/s, 12 bit, differ- ential, internal 1.25V reference		79		dBc
		200 kSamples/s, 12 bit, differ- ential, internal 2.5V reference		79		dBc
		200 kSamples/s, 12 bit, differ- ential, 5V reference		78		dBc
		200 kSamples/s, 12 bit, differ- ential, V _{DD} reference	68	79		dBc
		200 kSamples/s, 12 bit, differ- ential, 2xV _{DD} reference		79		dBc
	Offset voltage	After calibration, single ended	-4	0.3	4	mV
ADCOFFSET		After calibration, differential		0.3		mV
				-1.92		mV/°C
TGRAD _{ADCTH}	Thermometer out- put gradient			-6.3		ADC Codes/ °C
DNL _{ADC}	Differential non-lin- earity (DNL)	V_{DD} = 3.0 V, external 2.5V reference	-1	±0.7	4	LSB
INL _{ADC}	Integral non-linear- ity (INL), End point method	V _{DD} = 3.0 V, external 2.5V reference		±1.2	±3	LSB
MC _{ADC}	No missing codes		11.999 ¹	12		bits

¹On the average every ADC will have one missing code, most likely to appear around $2048 \pm n*512$ where n can be a value in the set {-3, -2, -1, 1, 2, 3}. There will be no missing code around 2048, and in spite of the missing code the ADC will be monotonic at all times so that a response to a slowly increasing input will always be a slowly increasing output. Around the one code that is missing, the neighbour codes will look wider in the DNL plot. The spectra will show spurs on the level of -78dBc for a full scale input for chips that have the missing code issue.

The integral non-linearity (INL) and differential non-linearity parameters are explained in Figure 3.26 (p. 36) and Figure 3.27 (p. 36), respectively.

3.10.1 Typical performance

Figure 3.28. ADC Frequency Spectrum, Vdd = 3V, Temp = 25°C



Figure 3.30. ADC Differential Linearity Error vs Code, Vdd = 3V, Temp = 25°C



Table 3.17. IDAC Range 1 Source

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
	Active current with	EM0, default settings		13.0		μA
IDAC	STEPSEL=0x10	Duty-cycled		10		nA
I _{0x10}	Nominal IDAC out- put current with STEPSEL=0x10			3.17		μA
I _{STEP}	Step size			0.097		μA
ID	Current drop at high impedance load	$V_{IDAC_OUT} = V_{DD} - 100mV$		0.79		%
TC _{IDAC}	Temperature coeffi- cient	V _{DD} = 3.0 V, STEPSEL=0x10		0.7		nA/°C
VC _{IDAC}	Voltage coefficient	T = 25 °C, STEPSEL=0x10		38.4		nA/V

Table 3.18. IDAC Range 1 Sink

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
I _{IDAC}	Active current with STEPSEL=0x10	EM0, default settings		17.9		μA
I _{0x10}	Nominal IDAC out- put current with STEPSEL=0x10			3.18		μA
I _{STEP}	Step size			0.098		μA
ID	Current drop at high impedance load	V _{IDAC_OUT} = 200 mV		0.20		%
TC _{IDAC}	Temperature coeffi- cient	V _{DD} = 3.0 V, STEPSEL=0x10		0.7		nA/°C
VC _{IDAC}	Voltage coefficient	T = 25 °C, STEPSEL=0x10		40.9		nA/V

Table 3.19. IDAC Range 2 Source

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
	Active current with	EM0, default settings		16.2		μA
IDAC	STEPSEL=0x10	Duty-cycled		10		nA
I _{0x10}	Nominal IDAC out- put current with STEPSEL=0x10			8.40		μA
I _{STEP}	Step size			0.493		μA
ID	Current drop at high impedance load	$V_{IDAC_OUT} = V_{DD} - 100mV$		1.26		%
TC _{IDAC}	Temperature coeffi- cient	V _{DD} = 3.0 V, STEPSEL=0x10		2.8		nA/°C
VCIDAC	Voltage coefficient	T = 25 °C, STEPSEL=0x10		96.6		nA/V

Table 3.20. IDAC Range 2 Sink

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
I _{IDAC}	Active current with STEPSEL=0x10	EM0, default settings	ettings			μA

Figure 3.34. IDAC Source Current as a function of voltage on IDAC_OUT



3.13 Voltage Comparator (VCMP)

Table 3.25. VCMP

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
V _{VCMPIN} Input voltage range				V _{DD}		V
V _{VCMPCM}	VCMP Common Mode voltage range			V _{DD}		V
IVCMP	Active current	BIASPROG=0b0000 and HALFBIAS=1 in VCMPn_CTRL register		0.1	0.8	μA
		BIASPROG=0b1111 and HALFBIAS=0 in VCMPn_CTRL register. LPREF=0.		14.7	35	μA
t _{VCMPREF} Startup time reference generator		NORMAL		10		μs
V _{VCMPOFFSET}	Offset voltage	Single ended		10		mV
		Differential		10		mV
V _{VCMPHYST}	VCMP hysteresis	hysteresis		17		mV
t _{VCMPSTART}	PSTART Startup time				10	μs

The V_{DD} trigger level can be configured by setting the TRIGLEVEL field of the VCMP_CTRL register in accordance with the following equation:

VCMP Trigger Level as a Function of Level Setting

V_{DD Trigger Level}=1.667V+0.034 ×TRIGLEVEL

3.14 I2C

Table 3.26. I2C Standard-mode (Sm)

Symbol	Parameter	Min	Тур	Max	Unit
f _{SCL}	SCL clock frequency	0		100 ¹	kHz
t _{LOW}	SCL clock low time	4.7			μs
t _{HIGH}	SCL clock high time	4.0			μs
t _{SU,DAT}	SDA set-up time	250			ns
t _{HD,DAT}	SDA hold time	8		3450 ^{2,3}	ns
t _{SU,STA}	Repeated START condition set-up time	4.7			μs
t _{HD,STA}	(Repeated) START condition hold time	4.0			μs
t _{SU,STO}	STOP condition set-up time	4.0			μs
t _{BUF}	Bus free time between a STOP and START condition	4.7			μs

¹For the minimum HFPERCLK frequency required in Standard-mode, see the I2C chapter in the EFM32ZG Reference Manual. ²The maximum SDA hold time (t_{HD,DAT}) needs to be met only when the device does not stretch the low time of SCL (t_{LOW}).

³When transmitting data, this number is guaranteed only when I2Cn_CLKDIV < ((3450*10⁻⁹ [s] * f_{HFPERCLK} [Hz]) - 5).

(3.2)

Table 3.27. I2C Fast-mode (Fm)

Symbol	Parameter	Min	Тур	Max	Unit
f _{SCL}	SCL clock frequency	0		400 ¹	kHz
t _{LOW}	SCL clock low time	1.3			μs
t _{HIGH}	SCL clock high time	0.6			μs
t _{SU,DAT}	SDA set-up time	100			ns
t _{HD,DAT}	SDA hold time	8		900 ^{2,3}	ns
t _{SU,STA}	Repeated START condition set-up time	0.6			μs
t _{HD,STA}	(Repeated) START condition hold time	0.6			μs
t _{SU,STO}	STOP condition set-up time	0.6			μs
t _{BUF}	Bus free time between a STOP and START condition	1.3			μs

¹For the minimum HFPERCLK frequency required in Fast-mode, see the I2C chapter in the EFM32ZG Reference Manual. ²The maximum SDA hold time ($t_{HD,DAT}$) needs to be met only when the device does not stretch the low time of SCL (t_{LOW}). ³When transmitting data, this number is guaranteed only when I2Cn_CLKDIV < ((900*10⁻⁹ [s] * f_{HFPERCLK} [Hz]) - 5).

Table 3.28. I2C Fast-mode Plus (Fm+)

Symbol	Parameter	Min	Тур	Max	Unit
f _{SCL}	SCL clock frequency	0		1000 ¹	kHz
t _{LOW}	SCL clock low time	0.5			μs
t _{HIGH}	SCL clock high time	0.26			μs
t _{SU,DAT}	SDA set-up time	50			ns
t _{HD,DAT}	SDA hold time	8			ns
t _{SU,STA}	Repeated START condition set-up time	0.26			μs
t _{HD,STA}	(Repeated) START condition hold time	0.26			μs
t _{SU,STO}	STOP condition set-up time	0.26			μs
t _{BUF}	Bus free time between a STOP and START condition	0.5			μs

¹For the minimum HFPERCLK frequency required in Fast-mode Plus, see the I2C chapter in the EFM32ZG Reference Manual.

3.15 Digital Peripherals

Table 3.29. Digital Peripherals

Symbol	Parameter	Condition	Min	Тур	Max	Unit
I _{USART}	USART current	USART idle current, clock en- abled		7.5		µA/ MHz
I _{LEUART}	LEUART current	LEUART idle current, clock en- abled	UART idle current, clock en- ed			nA
I _{I2C}	I2C current	I2C idle current, clock enabled 6.25		6.25		μΑ/ MHz
I _{TIMER}	TIMER current	TIMER_0 idle current, clock enabled		8.75		µA/ MHz
I _{PCNT}	PCNT current	PCNT idle current, clock en- abled		100		nA
I _{RTC}	RTC current	RTC idle current, clock enabled		100		nA



	QFP48 Pin# and Name	Pin Alternate Functionality / Description				
Pin #	Pin Name	Analog	Timers	Communication	Other	
3	PA2		TIM0_CC2 #0/1		CMU_CLK0 #0	
4	IOVDD_0	Digital IO power supply 0.				
5	VSS	Ground.				
6	PC0	ACMP0_CH0	TIM0_CC1 #4 PCNT0_S0IN #2	US1_TX #0 I2C0_SDA #4	PRS_CH2 #0	
7	PC1	ACMP0_CH1	TIM0_CC2 #4 PCNT0_S1IN #2	US1_RX #0 I2C0_SCL #4	PRS_CH3 #0	
8	PC2	ACMP0_CH2				
9	PC3	ACMP0_CH3				
10	PC4	ACMP0_CH4				
11	PB7	LFXTAL_P	TIM1_CC0 #3	US1_CLK #0		
12	PB8	LFXTAL_N	TIM1_CC1 #3	US1_CS #0		
13	PA8					
14	PA9					
15	PA10					
16	RESETn	Reset input, active low. To apply an external reset sou ensure that reset is released.	rce to this pin, it is required to o	nly drive this pin low during reset,	and let the internal pull-up	
17	PB11	IDAC0_OUT	TIM1_CC2 #3			
18	VSS	Ground.				
19	AVDD_1	Analog power supply 1.				
20	PB13	HFXTAL_P		LEU0_TX #1		
21	PB14	HFXTAL_N		LEU0_RX #1		
22	IOVDD_3	Digital IO power supply 3.				
23	AVDD_0	Analog power supply 0.				
24	PD4	ADC0_CH4		LEU0_TX #0		
25	PD5	ADC0_CH5		LEU0_RX #0		
26	PD6	ADC0_CH6	TIM1_CC0 #4 PCNT0_S0IN #3	US1_RX #2/3 I2C0_SDA #1	ACMP0_O #2	
27	PD7	ADC0_CH7	TIM1_CC1 #4 PCNT0_S1IN #3	US1_TX #2/3 I2C0_SCL #1	CMU_CLK0 #2	
28	VDD_DREG	Power supply for on-chip voltage	ge regulator.			
29	DECOUPLE	Decouple output for on-chip vo	ltage regulator. An external cap	acitance of size C _{DECOUPLE} is req	uired at this pin.	
30	PC8					
31	PC9				GPIO_EM4WU2	
32	PC10					
33	PC11					
34	PC13		TIM1_CC0 #0 TIM1_CC2 #4 PCNT0_S0IN #0			
35	PC14		TIM1_CC1 #0 PCNT0_S1IN #0	US1_CS #3	PRS_CH0 #2	
36	PC15		TIM1_CC2 #0	US1_CLK #3	PRS_CH1 #2	
37	PF0		TIM0_CC0 #5	US1_CLK #2	DBG_SWCLK #0	

Updated Cortex M0 related items in the memory map.

7.9 Revision 0.10

June 7th, 2011

Initial preliminary release.